Application/Control No. 10/054,735 Applicant(s)/Patent Under Reexamination NAKAMURA ET AL. Examiner Huy D Nguyen Art Unit Page 1 of 1

U.S. PATENT DOCUMENTS

	U.S. FAIENT DOCUMENTS						
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification		
	Α	US-6,594,490	07-2003	Toyoda et al.	455/433		
	В	US-6,408,181	06-2002	Ho et al.	455/432.1		
	С	US-					
	D	US-					
	Е	US-					
	F	US-					
	G	US-					
	Н	US-					
	1	US-					
	J	US-					
	К	US-					
	L	US-					
	М	US-					

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification	
	N						
	0						
	Р						
	Q						
	R						
	S						
	Т						

NON-PATENT DOCUMENTS

	TOTAL ALERT DOGGLETTO						
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	٦						
	>						
	W						
	x						

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.